Search Notes



Application/Control No.

10049522

Reexamination
HEYMANN ET AL.

Applicant(s)/Patent Under

Examiner

Bhatia, Ajay M

Art Unit

2145

SEARCHED

Class	Subclass	Date	Examiner
709	226 w/text	5/7/07	AB

SEARCH NOTES

Search Notes	Date	Examiner	
East classification and text search	5/7/07	AB	

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
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U.S. Patent and Trademark Office Part of Paper No.: 20070507